Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/662,656	BARCHI ET AL.	
Examiner	Art Unit	
Ellen C. Tran	2134	

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SEARCHED						
Class	Subclass	Date	Examiner			
713	182	10/16/2007	ĘΤ			
726	8	10/16/2007	ΈT			
380	270	10/16/2007	ET			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
					
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	10/16/2007	ET			
NPL - IÉEE XPLORE	10/16/2007	ET			
ALL CLAIMS WERE REVIEWED FOR POSSIBLE 101 REJECTION	10/16/2007	ET			
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